Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/825,339	SHIRAHATA ET AL.
Examiner	Art Unit
TUYEN T. NGUYEN	2832

:	SEARCHED					
Class	Subclass	Date	Examiner			
336	57, 58, 60, 61, 69, 210-213,	7/19/2005	TTN			
336	216, 233	7/19/2005	TTN			
336	234	7/19/2005	TTN			
	-	"	, .			
	 					

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			
	<u></u>		

SEARCH (INCLUDING SEAF	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
		<u> </u>	
		<u> </u>	